FCC D₀C TEST REPORT

Report No.: 81014202-F

for

Fanless Embedded Controller

MODEL: xxxxxAEC-6410-xxxxxx

Test Report Number: 81014202-F

Issued to:

AAEON Technology Inc.

5F, No. 135, Lane 235, Pao Chiao Rd., Hsin-Tien City, Taipei, Taiwan, R.O.C.

Issued by:

Compliance Certification Services Inc.

Sindian BU.

No.163-1, Jhongsheng Rd., Sindian City, Taipei County 23151, Taiwan TEL: 886-2-22170894

FAX: 886-2-22171029

Issued Date: October 20, 2008







Note: This report shall not be reproduced except in full, without the written approval of Compliance Certification Services Inc. This document may be altered or revised by Compliance Certification Services Inc. personnel only, and shall be noted in the revision section of the document. The client should not use it to claim product endorsement by TAF, A2LA, NVLAP, NIST or any government agencies. The test results in the report only apply to the tested sample.



Revision History

Rev.	Issue Date	Revisions	Effect Page	Revised By
00		Initial Issue	ALL	

Report No.: 81014202-F

TABLE OF CONTENTS

2 EUT DESCRIPTION	1	TEST RESULT CERTIFICATION	4
3.1. DECISION OF FINAL TEST MODE 6 3.2. EUT SYSTEM OPERATION 6 4 SETUP OF EQUIPMENT UNDER TEST 7 4.1. DESCRIPTION OF SUPPORT UNITS 7 4.2. CONFIGURATION OF SYSTEM UNDER TEST 8 5 FACILITIES AND ACCREDITATIONS 9 5.1. FACILITIES 9 5.2. ACCREDITATIONS 9 5.3. MEASUREMENT UNCERTAINTY 9 6 CONDUCTED EMISSION MEASUREMENT 10 6.1. LIMITS OF CONDUCTED EMISSION MEASUREMENT 10 6.2. TEST INSTRUMENTS 10 6.3. TEST PROCEDURES 11 6.4. TEST SETUP 12 6.5. DATA SAMPLE 12 6.6. TEST RESULTS 12 7 RADIATED EMISSION MEASUREMENT 14 7.1. LIMITS OF RADIATED EMISSION MEASUREMENT 14 7.2. TEST INSTRUMENTS 12 7.3. TEST PROCEDURES 15 7.4. TEST SETUP 17 7.5. DATA SAMPLE 17 7.6. TEST RESULTS 18	2		
3.2. EUT SYSTEM OPERATION 6 4 SETUP OF EQUIPMENT UNDER TEST 7 4.1. DESCRIPTION OF SUPPORT UNITS 7 4.2. CONFIGURATION OF SYSTEM UNDER TEST 8 5 FACILITIES AND ACCREDITATIONS 9 5.1. FACILITIES 9 5.2. ACCREDITATIONS 9 5.3. MEASUREMENT UNCERTAINTY 9 6 CONDUCTED EMISSION MEASUREMENT 10 6.1. LIMITS OF CONDUCTED EMISSION MEASUREMENT 10 6.2. TEST INSTRUMENTS 10 6.3. TEST PROCEDURES 11 6.4. TEST SETUP 12 6.5. DATA SAMPLE 12 6.6. TEST RESULTS 12 7 RADIATED EMISSION MEASUREMENT 14 7.1. LIMITS OF RADIATED EMISSION MEASUREMENT 14 7.2. TEST INSTRUMENTS 12 7.3. TEST PROCEDURES 15 7.4. TEST SETUP 17 7.5. DATA SAMPLE 17 7.6. TEST RESULTS 18	3	TEST METHODOLOGY	6
4 SETUP OF EQUIPMENT UNDER TEST 7 4.1. DESCRIPTION OF SUPPORT UNITS 7 4.2. CONFIGURATION OF SYSTEM UNDER TEST 8 5 FACILITIES AND ACCREDITATIONS 9 5.1. FACILITIES 9 5.2. ACCREDITATIONS 9 5.3. MEASUREMENT UNCERTAINTY 9 6 CONDUCTED EMISSION MEASUREMENT 10 6.1. LIMITS OF CONDUCTED EMISSION MEASUREMENT 10 6.2. TEST INSTRUMENTS 10 6.3. TEST PROCEDURES 11 6.4. TEST SETUP 12 6.5. DATA SAMPLE 12 6.6. TEST RESULTS 12 7.1. LIMITS OF RADIATED EMISSION MEASUREMENT 14 7.1. LIMITS OF RADIATED EMISSION MEASUREMENT 14 7.2. TEST INSTRUMENTS 12 7.3. TEST PROCEDURES 15 7.4. TEST SETUP 17 7.5. DATA SAMPLE 17 7.6. TEST RESULTS 18	3.1.		
4.1. DESCRIPTION OF SUPPORT UNITS 7 4.2. CONFIGURATION OF SYSTEM UNDER TEST 8 5 FACILITIES AND ACCREDITATIONS 9 5.1. FACILITIES 9 5.2. ACCREDITATIONS 9 5.3. MEASUREMENT UNCERTAINTY 9 6 CONDUCTED EMISSION MEASUREMENT 10 6.1. LIMITS OF CONDUCTED EMISSION MEASUREMENT 10 6.2. TEST INSTRUMENTS 10 6.3. TEST PROCEDURES 11 6.4. TEST SETUP 12 6.5. DATA SAMPLE 12 6.6. TEST RESULTS 12 7.1. LIMITS OF RADIATED EMISSION MEASUREMENT 14 7.2. TEST INSTRUMENTS 14 7.3. TEST PROCEDURES 15 7.4. TEST SETUP 17 7.5. DATA SAMPLE 17 7.6. TEST RESULTS 18	3.2.	EUT SYSTEM OPERATION	6
4.2. CONFIGURATION OF SYSTEM UNDER TEST 8 5 FACILITIES AND ACCREDITATIONS 9 5.1. FACILITIES 9 5.2. ACCREDITATIONS 9 5.3. MEASUREMENT UNCERTAINTY 9 6 CONDUCTED EMISSION MEASUREMENT 10 6.1. LIMITS OF CONDUCTED EMISSION MEASUREMENT 10 6.2. TEST INSTRUMENTS 10 6.3. TEST PROCEDURES 11 6.4. TEST SETUP 12 6.5. DATA SAMPLE 12 6.6. TEST RESULTS 12 7.1. LIMITS OF RADIATED EMISSION MEASUREMENT 14 7.2. TEST INSTRUMENTS 14 7.3. TEST PROCEDURES 15 7.4. TEST SETUP 15 7.5. DATA SAMPLE 17 7.5. DATA SAMPLE 17 7.6. TEST RESULTS 18	4		
5 FACILITIES AND ACCREDITATIONS 9 5.1 FACILITIES 9 5.2 ACCREDITATIONS 9 5.3 MEASUREMENT UNCERTAINTY 9 6 CONDUCTED EMISSION MEASUREMENT 10 6.1 LIMITS OF CONDUCTED EMISSION MEASUREMENT 10 6.2 TEST INSTRUMENTS 10 6.3 TEST PROCEDURES 11 6.4 TEST SETUP 12 6.5 DATA SAMPLE 12 6.6 TEST RESULTS 13 7 RADIATED EMISSION MEASUREMENT 14 7.1 LIMITS OF RADIATED EMISSION MEASUREMENT 14 7.2 TEST INSTRUMENTS 14 7.3 TEST PROCEDURES 15 7.4 TEST SETUP 15 7.5 DATA SAMPLE 17 7.6 TEST RESULTS 18	4.1.		
5.1. FACILITIES 9 5.2. ACCREDITATIONS 9 5.3. MEASUREMENT UNCERTAINTY 9 6 CONDUCTED EMISSION MEASUREMENT 10 6.1. LIMITS OF CONDUCTED EMISSION MEASUREMENT 10 6.2. TEST INSTRUMENTS 10 6.3. TEST PROCEDURES 11 6.4. TEST SETUP 12 6.5. DATA SAMPLE 12 6.6. TEST RESULTS 13 7 RADIATED EMISSION MEASUREMENT 14 7.1. LIMITS OF RADIATED EMISSION MEASUREMENT 14 7.2. TEST INSTRUMENTS 14 7.3. TEST PROCEDURES 15 7.4. TEST SETUP 17 7.5. DATA SAMPLE 17 7.6. TEST RESULTS 18	4.2.	CONFIGURATION OF SYSTEM UNDER TEST	8
5.2. ACCREDITATIONS 9 5.3. MEASUREMENT UNCERTAINTY 9 6 CONDUCTED EMISSION MEASUREMENT 10 6.1. LIMITS OF CONDUCTED EMISSION MEASUREMENT 10 6.2. TEST INSTRUMENTS 10 6.3. TEST PROCEDURES 11 6.4. TEST SETUP 12 6.5. DATA SAMPLE 12 6.6. TEST RESULTS 13 7 RADIATED EMISSION MEASUREMENT 14 7.1. LIMITS OF RADIATED EMISSION MEASUREMENT 14 7.2. TEST INSTRUMENTS 12 7.3. TEST PROCEDURES 15 7.4. TEST SETUP 17 7.5. DATA SAMPLE 17 7.6. TEST RESULTS 18	5	FACILITIES AND ACCREDITATIONS	9
5.3. MEASUREMENT UNCERTAINTY 9 6 CONDUCTED EMISSION MEASUREMENT 10 6.1. LIMITS OF CONDUCTED EMISSION MEASUREMENT 10 6.2. TEST INSTRUMENTS 10 6.3. TEST PROCEDURES 11 6.4. TEST SETUP 12 6.5. DATA SAMPLE 12 6.6. TEST RESULTS 13 7 RADIATED EMISSION MEASUREMENT 14 7.1. LIMITS OF RADIATED EMISSION MEASUREMENT 14 7.2. TEST INSTRUMENTS 12 7.3. TEST PROCEDURES 15 7.4. TEST SETUP 17 7.5. DATA SAMPLE 17 7.6. TEST RESULTS 18	5.1.		
6 CONDUCTED EMISSION MEASUREMENT 10 6.1. LIMITS OF CONDUCTED EMISSION MEASUREMENT 10 6.2. TEST INSTRUMENTS 10 6.3. TEST PROCEDURES 11 6.4. TEST SETUP 12 6.5. DATA SAMPLE 12 6.6. TEST RESULTS 13 7 RADIATED EMISSION MEASUREMENT 14 7.1. LIMITS OF RADIATED EMISSION MEASUREMENT 14 7.2. TEST INSTRUMENTS 14 7.3. TEST PROCEDURES 15 7.4. TEST SETUP 17 7.5. DATA SAMPLE 17 7.6. TEST RESULTS 18	5.2.		
6.1. LIMITS OF CONDUCTED EMISSION MEASUREMENT 10 6.2. TEST INSTRUMENTS 10 6.3. TEST PROCEDURES 11 6.4. TEST SETUP 12 6.5. DATA SAMPLE 12 6.6. TEST RESULTS 13 7 RADIATED EMISSION MEASUREMENT 14 7.1. LIMITS OF RADIATED EMISSION MEASUREMENT 14 7.2. TEST INSTRUMENTS 14 7.3. TEST PROCEDURES 15 7.4. TEST SETUP 17 7.5. DATA SAMPLE 17 7.6. TEST RESULTS 18	5.3.		
6.2. TEST INSTRUMENTS 10 6.3. TEST PROCEDURES 11 6.4. TEST SETUP 12 6.5. DATA SAMPLE 12 6.6. TEST RESULTS 13 7 RADIATED EMISSION MEASUREMENT 14 7.1. LIMITS OF RADIATED EMISSION MEASUREMENT 14 7.2. TEST INSTRUMENTS 14 7.3. TEST PROCEDURES 15 7.4. TEST SETUP 17 7.5. DATA SAMPLE 17 7.6. TEST RESULTS 18	6		
6.3. TEST PROCEDURES 11 6.4. TEST SETUP 12 6.5. DATA SAMPLE 12 6.6. TEST RESULTS 13 7 RADIATED EMISSION MEASUREMENT 14 7.1. LIMITS OF RADIATED EMISSION MEASUREMENT 14 7.2. TEST INSTRUMENTS 14 7.3. TEST PROCEDURES 15 7.4. TEST SETUP 17 7.5. DATA SAMPLE 17 7.6. TEST RESULTS 18			
6.4. TEST SETUP 12 6.5. DATA SAMPLE 12 6.6. TEST RESULTS 13 7 RADIATED EMISSION MEASUREMENT 14 7.1. LIMITS OF RADIATED EMISSION MEASUREMENT 14 7.2. TEST INSTRUMENTS 14 7.3. TEST PROCEDURES 15 7.4. TEST SETUP 17 7.5. DATA SAMPLE 17 7.6. TEST RESULTS 18			
6.5. DATA SAMPLE 12 6.6. TEST RESULTS 13 7 RADIATED EMISSION MEASUREMENT 14 7.1. LIMITS OF RADIATED EMISSION MEASUREMENT 12 7.2. TEST INSTRUMENTS 14 7.3. TEST PROCEDURES 15 7.4. TEST SETUP 17 7.5. DATA SAMPLE 17 7.6. TEST RESULTS 18			
6.6. TEST RESULTS	6.4.		
7 RADIATED EMISSION MEASUREMENT 14 7.1. LIMITS OF RADIATED EMISSION MEASUREMENT 12 7.2. TEST INSTRUMENTS 14 7.3. TEST PROCEDURES 15 7.4. TEST SETUP 17 7.5. DATA SAMPLE 17 7.6. TEST RESULTS 18	6.5.		
7.1. LIMITS OF RADIATED EMISSION MEASUREMENT147.2. TEST INSTRUMENTS147.3. TEST PROCEDURES157.4. TEST SETUP177.5. DATA SAMPLE177.6. TEST RESULTS18	6.6.		
7.2. TEST INSTRUMENTS 14 7.3. TEST PROCEDURES 15 7.4. TEST SETUP 17 7.5. DATA SAMPLE 17 7.6. TEST RESULTS 18	7		
7.3. TEST PROCEDURES 15 7.4. TEST SETUP 17 7.5. DATA SAMPLE 17 7.6. TEST RESULTS 18			
7.4. TEST SETUP 17 7.5. DATA SAMPLE 17 7.6. TEST RESULTS 18			
7.5. DATA SAMPLE 17.6. TEST RESULTS 18			
7.6. TEST RESULTS			
8 PHOTOGRAPHS OF THE TEST CONFIGURATION	7.6.		
	8	PHOTOGRAPHS OF THE TEST CONFIGURATION	20



1 TEST RESULT CERTIFICATION

Product: Fanless Embedded Controller

Model: xxxxxAEC-6410-xxxxxxx(Where x is 0-9, A-Z, - or blank)

Brand: AAEON

Applicant: AAEON Technology Inc.

5F, No. 135, Lane 235, Pao Chiao Rd., Hsin-Tien City,

Taipei, Taiwan, R.O.C.

Manufacturer: AAEON Technology Inc.

5F, No. 135, Lane 235, Pao Chiao Rd., Hsin-Tien City,

Taipei, Taiwan, R.O.C.

Tested: October 14, 2008 ~ October 17, 2008

EMISSION				
Standard	Item	Result	Remarks	
FCC 47 CFR Part 13 Subpart B,	Conducted (Main Port)	PASS	Meet Class A limit	
ICES-003 Issue 4 ANSI C63.4-2003	Radiated	PASS	Meet Class A limit	

Note:

- 1. The statements of test result on the above are decided by the request of test standard only; the measurement uncertainties are not factored into this compliance determination.
- 2. The information of measurement uncertainty is available upon the customer's request.

Deviation from Applicable Standard	
None	

The above equipment has been tested by Compliance Certification Services Inc., and found compliance with the requirements set forth in the technical standards mentioned above. The results of testing in this report apply only to the product/system, which was tested. Other similar equipment will not necessarily produce the same results due to production tolerance and measurement uncertainties.

Approved by:

Vince Chiang

Assistant Manager of Sindian BU.

Reviewed by:

Vesta Hsu

Supervisor of report document dept. of Sindian BU.

2 EUT DESCRIPTION

Product	Fanless Embedded Controller
Brand Name	AAEON
Model	xxxxxAEC-6410-xxxxxxx(Where x is 0-9, A-Z, - or blank)
Applicant	AAEON Technology Inc.
Housing material	Metal case
Serial Number	N/A
Received Date	October 14, 2008
AC Power During Test	120VAC / 60Hz to AC Adaptor
EUT Power Rating	12VDC from AC Adaptor
AC Adaptor Manufacturer	EDAC
AC Adaptor Model Number	EA1050A-120
Power Adaptor Power Rating	IP: 100-240VAC, 50-60Hz; OP: 12VDC
DC Power Cord Type	Unshielded, 1.8m (Non-Detachable, with a core) to AC Adaptor
OSC/Clock Frequencies	14.31818MHz; 25MHz; 32.768KHz; 24.576MHz

Report No.: 81014202-F

I/O PORT

	I/O PORT TYPES	Q'TY	TESTED WITH
1.	PIO Port	1	1
2.	VGA Port	1	1
3.	Audio In Port	1	1
4.	Microphone Port	1	1
5.	Earphone Port	1	1
6.	USB 2.0 Port	4	4
7.	LAN Port	2	2
8.	RS-232 Port	2	2

Note: Client consigns only one model sample to test (Model Number: AEC-6410).

3 TEST METHODOLOGY

3.1. DECISION OF FINAL TEST MODE

The EUT was tested together with the above additional components, and a configuration, which produced the worst emission levels, was selected and recorded in this report.

Report No.: 81014202-F

The test configuration/ mode is as the following:

Conduction Mode:

1. Normal Mode

Radiation Mode(s):

1. Normal Mode
Normal Mode / 1-5GHz

Conduction: Mode 1 **Radiation:** Mode 1

3.2. EUT SYSTEM OPERATION

- 1. Windows XP boots system.
- 2. Run Emctest.exe to activate all peripherals and display "H" pattern on monitor screen.
- 3. Run windows media player to play music.
- 4. Run Winthrax.exe and choose "C:/→E:/, E:/→F:/, F:/→C:/" to test USB 2.0 port.
- 5. Press the start menu, select executive and type ping 192.168.0.20 –t (EUT), ping 192.168.0.10 –t (Server Notebook).
- 6. Press the start menu, select executive and type ping 192.168.0.21 –t (EUT), ping 192.168.0.11 –t (Server Notebook).

Note: Test program is self-repeating throughout the test.

4 SETUP OF EQUIPMENT UNDER TEST

4.1. DESCRIPTION OF SUPPORT UNITS

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

Report No.: 81014202-F

EUT Devices:

No.	Equipment	Model No.	Trade Name
1	CPU (500MHz)	Geode-LX	AMD
2	Memory (DDR2-333, SDRM512MB)	K4H510838D-UCCC	SAMSUNG
3	CF Card (4GB)	N/A	Transcend
4	Power Supply	EA1050A-120	EDAC

Peripherals Devices:

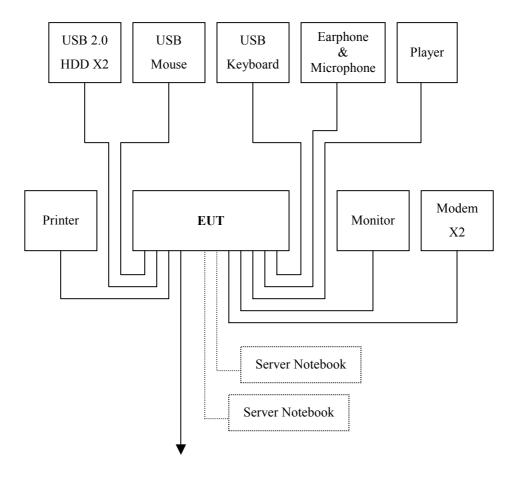
No.	Equipment	Model No.	Serial No.	FCC ID / BSMI ID	Trade Name	Data Cable	Power Cord
1~2	USB 2.0 HDD	F12-U	N/A	BSMI ID: 4912A002	TeraSys	Shielded, 1.8m	N/A
3	USB Mouse	M056U0	E16029R8	N/A	DELL	Shielded, 1.8m	N/A
4	USB Keyboard	Y-BL49	STW42600036	DOC BSMI: R41126	LOGITECH	Shielded, 1.8m	N/A
5	Earphone & Microphone	MSB301	N/A	N/A	e-Sense	Unshielded, 1.8m	N/A
6	Player	RQ-L11LT	N/A	BSMI ID: 3912A162	Panasonic	Unshielded, 1.2m	N/A
7	Printer	C60	DR3K039402	BSMI ID: 3902E006	EPSON	Shielded, 1.8m	Unshielded, 1.8m
8	Monitor	710V	GS17H9NXA05858E	DOC BSMI: R33475	SAMAUNG	Shielded, 1.8m with two cores	Unshielded, 1.8m
9~10	Modem	5JEG4033MKO	N/A	5RJTAI-35500-M5-E	TOP- SOLUTION	Shielded, 1.8m	Unshielded, 1.8m
11	Server Notebook	Compaq 2210b	CNU7472KDP	DOC BSMI: R33001	НР	Unshielded, 20m	Unshielded, 1.8m
12	Server Notebook	2210B	CNV7472KG5	DOC BSMI: R33001	НР	Unshielded, 20m	Unshielded, 1.8m

Note:

- 1) All the equipment/cables were placed in the worst-case configuration to maximize the emission during the test.
- 2) Grounding was established in accordance with the manufacturer's requirements and conditions for the intended use.



4.2. CONFIGURATION OF SYSTEM UNDER TEST



5 FACILITIES AND ACCREDITATIONS

5.1. FACILITIES

All measurement facilities used to collect the measurement data are located at CCS Taiwan Sindian BU. at No.163-1, Jhongsheng Rd., Sindian City, Taipei County 23151, Taiwan.

Report No.: 81014202-F

The sites are constructed in conformance with the requirements of ANSI C63.4 and CISPR Publication 22. All receiving equipment conforms to CISPR 16-1-1, CISPR 16-1-2, CISPR 16-1-3, CISPR 16-1-4 and CISPR 16-1-5.

5.2. ACCREDITATIONS

Our laboratories are accredited and approved by the following accreditation body according to ISO/IEC 17025.

Taiwan	TAF
USA	A2LA

The measuring facility of laboratories has been authorized or registered by the following approval agencies.

Canada	Industry Canada
Germany	TUV Rheinland
Japan	VCCI
Taiwan	BSMI
LISA	FCC

Copies of granted accreditation certificates are available for downloading from our web site, http://www.ccsemc.com.tw

5.3. MEASUREMENT UNCERTAINTY

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2:

Measurement	Frequency	Uncertainty
Conducted emissions	0.15MHz~30MHz	± 1.7376
Radiated emissions	30MHz ~ 200MHz	± 3.8792
Radiated emissions	200MHz ~1000MHz	± 3.8914

This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

Consistent with industry standard (e.g. CISPR 22: 2006, clause 11, Measurement Uncertainty) determining compliance with the limits shall be base on the results of the compliance measurement. Consequently the measure emissions being less than the maximum allowed emission result in this be a compliant test or passing test.

The acceptable measurement uncertainty value without requiring revision of the compliance statement is base on conducted and radiated emissions being less than U_{CISPR} which is 3.6dB and 5.2dB respectively. CCS values (called U_{Lab} in CISPR 16-4-2) is less than U_{CISPR} as shown in the table above. Therefore, MU need not be considered for compliance.

6 CONDUCTED EMISSION MEASUREMENT

6.1. LIMITS OF CONDUCTED EMISSION MEASUREMENT

FREQUENCY (MHz)	Class A	(dBuV)	Class B (dBuV)		
FREQUENCI (MIIZ)	Quasi-peak	Average	Quasi-peak	Average	
0.15 - 0.5	79	66	66 - 56	56 - 46	
0.50 - 5.0	73	60	56	46	
5.0 - 30.0	73	60	60	50	

Report No.: 81014202-F

NOTE:

- (1) The lower limit shall apply at the transition frequencies.
- (2) The limit decreases in line with the logarithm of the frequency in the range of 0.15 to 0.50 MHz.
- (3) All emanations from a class A/B digital device or system, including any network of conductors and apparatus connected thereto, shall not exceed the level of field strengths specified above.

6.2. TEST INSTRUMENTS

Conducted Emission room # A								
Name of Equipment	Manufacturer Model		Serial Number	Calibration Due				
TEST RECEIVER	R&S	ESHS20	840455/006	02/18/2009				
LISN (EUT)	SCHWARZBECK	NSLK 8127	8127382	12/03/2008				
LISN	SOLAR	8012-50-R-24-BNC	8305114	12/03/2008				
BNC CABLE	MIYAZAKI	5D-FB	BNC A4	05/12/2009				
THERMO- HYGRO METER	TECPEL	DTM-303	No.7	11/15/2008				
Test S/W	EMI 32.exe							

NOTE: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. $N.C.R = No\ Calibration\ Request.$

6.3. TEST PROCEDURES (please refer to measurement standard or CCS SOP PA-031)

Procedure of Preliminary Test

• The EUT and Support equipment, if needed, was set up as per the test configuration to simulate typical usage per the user's manual. When the EUT is a tabletop system, a wooden table with a height of 0.8 meters is used and is placed on the ground plane as per ANSI C63.4 (see Test Facility for the dimensions of the ground plane used). When the EUT is a floor standing equipment, it is placed on the ground plane, which has a 12 mm non-conductive covering to insulate the EUT from the ground plane.

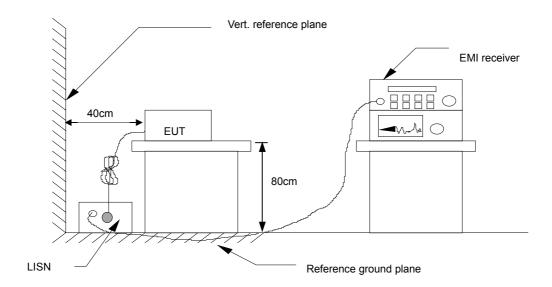
Report No.: 81014202-F

- All I/O cables were positioned to simulate typical actual usage as per ANSI C63.4.
- The test equipment EUT installed received AC main power, through a Line Impedance Stabilization Network (LISN), which supplied power source and was grounded to the ground plane.
- All support equipment power received from a second LISN.
- The EUT test program was started. Emissions were measured on each current carrying line of the EUT using an EMI Test Receiver connected to the LISN powering the EUT.
- The Receiver scanned from 150kHz to 30MHz for emissions in each of the test modes.
- During the above scans, the emissions were maximized by cable manipulation.
- The test mode(s) described in Item 3.1 were scanned during the preliminary test.
- After the preliminary scan, we found the test mode described in Item 3.1 producing the highest emission level.
- The EUT configuration and cable configuration of the above highest emission levels were recorded for reference of the final test.

Procedure of Final Test

- EUT and support equipment were set up on the test bench as per the configuration with highest emission level in the preliminary test.
- A scan was taken on both power lines, Line 1 and Line 2, recording at least the six highest
 emissions. Emission frequency and amplitude were recorded into a computer in which
 correction factors were used to calculate the emission level and compare reading to the
 applicable limit.
- The test data of the worst-case condition(s) was recorded.

6.4. TEST SETUP



• For the actual test configuration, please refer to the related item - Photographs of the Test Configuration.

6.5. DATA SAMPLE

Freq. (MHz)	Read Level (dBuV)	Factor (dB)	Level (dBuV)	Limit Line (dBuV)	Over Limit (dB)	Remark (P/Q/A)	Line (L1/L2)
x.xx	42.95	0.55	43.50	73	-29.50	Q	L1

Freq. = Emission frequency in MHz

Read Level = Uncorrected Analyzer/Receiver reading Factor = Insertion loss of LISN + Cable Loss

Level = Read Level + Factor
Limit Line = Limit stated in standard
Over Limit = Reading in reference to limit

P = Peak Reading
Q = Quasi-peak Reading
A = Average Reading

L1 = Hot side L2 = Neutral side

Calculation Formula

Over Limit (dB) = Level (dBuV) – Limit Line (dBuV)

6.6. TEST RESULTS

Model No.	AEC-6410	6dB Bandwidth	10 KHz
Environmental Conditions	24deg.C, 65% RH, 1010 hPa	Test Mode	Mode 1
Tested by	Howard Peng		

Report No.: 81014202-F

(The chart below shows the highest readings taken from the final data.)

Six Highest Conducted Emission Readings								
Frequency Range Investigated				150 KHz to	30 MHz			
Freq. (MHz)	Read Level (dBuV)	Factor (dB)	Level (dBuV)	Limit Line (dBuV)	Over Limit (dB)	Remark (P/Q/A)	Line (L1/L2)	
0.182	57.41	0.12	57.53	79.00	-21.47	P	L1	
0.243	47.11	0.12	47.23	79.00	-31.77	P	L1	
0.182	56.87	0.14	57.01	79.00	-21.99	P	L2	
0.246	47.07	0.14	47.21	79.00	-31.79	P	L2	
0.305	43.89	0.14	44.03	79.00	-34.97	P	L2	
2.900	37.19	0.31	37.50	73.00	-35.50	P	L2	

NOTE: 1. L1 = Line One (Live Line) / L2 = Line Two (Neutral Line)

^{2.} The emission level was or more than 2dB below the Average limit, so no re-check anymore.

7 RADIATED EMISSION MEASUREMENT

7.1. LIMITS OF RADIATED EMISSION MEASUREMENT

FREQUENCY (MHz)	dBuV/m (At 10m)			
FREQUENCT (MIIZ)	Class A	Class B		
30 ~ 230	40	30		
230 ~ 1000	47	37		

Report No.: 81014202-F

NOTE: (1) The lower limit shall apply at the transition frequencies.

(2) Emission level $(dBuV/m) = 20 \log Emission level (uV/m)$.

7.2. TEST INSTRUMENTS

Open Area Test Site # I								
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due				
MEASURE RECEIVER	SCHAFFNER	SCR3501	338	07/07/2009				
SPECTRUM ANALYZER	ADVANTEST	R3132	120900008	No Calibration Required				
ANTENNA	SCHAFFNER	CBL 6112B	2809	09/08/2009				
AMPLIFIER	SCHAFFNER	CPA9231A	3626	10/12/2009				
CABLE	BELDEN	9913	N-TYPE #I2	02/24/2009				
THERMO- HYGRO METER	TFA	TFA N/A		12/03/2008				
Test S/W		Lab VII	EW 7.1					
	Ab	ove 1GHz Used						
SPECTRUM ANALYZER (9kHz-30GHz)	R&S	FSP 30	100112	10/14/2009				
ANTENNA (1-18GHz)	EMCO	3115	00022256	01/30/2009				
AMPLIFIER (1-18GHz)	НР	8449B	3008A01266	01/28/2009				
CABLE (1-18GHz)	JYEBAO	LL142	SMA#RS1	01/28/2009				
CABLE (1-18GHz)	HUBER +SUHNER	SUCOFLEX 104	SMA#RS3	01/28/2009				
CABLE (1-18GHz)	JYEBAO	LL142	SMA#C1	01/28/2009				
Test S/W		EMI 3	2.exe					

NOTE: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. $N.C.R = No\ Calibration\ Request.$



7.3. TEST PROCEDURES (please refer to measurement standard or CCS SOP PA-031)

Procedure of Preliminary Test

The equipment was set up as per the test configuration to simulate typical usage per the user's manual. When the EUT is a tabletop system, a wooden turntable with a height of 0.8 meters is used which is placed on the ground plane. When the EUT is a floor standing equipment, it is placed on the ground plane which has a 12 mm non-conductive covering to insulate the EUT from the ground plane.

- Support equipment, if needed, was placed as per ANSI C63.4.
- All I/O cables were positioned to simulate typical usage as per ANSI C63.4.
- The EUT received AC power source from the outlet socket under the turntable. All support equipment power received from another socket under the turntable.
- The antenna was placed at 10 meter away from the EUT as stated in ANSI C63.4. The antenna connected to the Spectrum Analyzer via a cable and at times a pre-amplifier would be used.
- The Analyzer / Receiver quickly scanned from 30MHz to 5000MHz. The EUT test program was started. Emissions were scanned and measured rotating the EUT to 360 degrees and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.
- The test mode(s) described in Item 3.1 were scanned during the preliminary test:
- After the preliminary scan, we found the test mode described in Item 3.1 producing the highest emission level.
- The EUT and cable configuration, antenna position, polarization and turntable position of the above highest emission level were recorded for the final test.



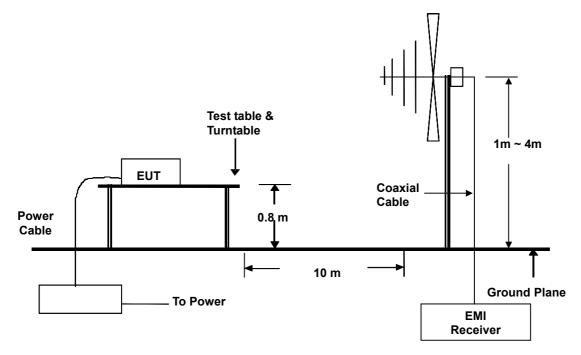
Procedure of Final Test

EUT and support equipment were set up on the turntable as per the configuration with highest emission level in the preliminary test.

- The Analyzer / Receiver scanned from 30MHz to 5000MHz. Emissions were scanned and measured rotating the EUT to 360 degrees, varying cable placement and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.

•	polarization and turntable position were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit and only Q.P. reading is presented.
•	The test data of the worst-case condition(s) was recorded.

7.4. TEST SETUP



• For the actual test configuration, please refer to the related item - Photographs of the Test Configuration.

7.5. DATA SAMPLE

Freq. (MHz)	Reading (dBuV/m)	Factor (dB)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Remark (P/Q/A)	Pol. (H/V)
x.xx	14.0	12.2	26.2	40	-13.8	Q	Н

Freq. = Emission frequency in MHz

Reading = Uncorrected Analyzer/Receiver reading

Factor = Antenna Factor + Cable Loss + Attenuator (3/6/10dB) – Amplifier Gain

Result = Reading + Factor

Limit = Limit stated in standard Margin = Reading in reference to limit

P = Peak Reading Q = Quasi-peak Reading A = Average Reading

H = Antenna Polarization: Horizontal V = Antenna Polarization: Vertical

Calculation Formula

Margin (dB) = Result (dBuV/m) – Limit (dBuV/m)

7.6. TEST RESULTS

Model No.	AEC-6410	Test Mode	Mode 1
Environmental Conditions	25deg.C, 55% RH, 1005 hPa	6dB Bandwidth	120 KHz
Antenna Pole	Vertical	Antenna Distance	10m
Detector Function	Quasi-peak.	Tested by	John Yen

Report No.: 81014202-F

(The chart below shows the highest readings taken from the final data.)

	Six Highest Radiated Emission Readings							
Free	Frequency Range Investigated			30 N	1Hz to 1000	MHz at 10	m	
Freq. (MHz)	Reading (dBuV)	Factor (dB)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Remark (P/Q/A)	Pol. (H/V)	
31.996	42.00	-11.48	30.52	40.00	-9.48	Q	V	
48.009	47.60	-17.31	30.29	40.00	-9.71	Q	V	
68.020	52.78	-22.24	30.54	40.00	-9.46	Q	V	
72.009	53.00	-21.91	31.09	40.00	-8.90	Q	V	
212.040	47.56	-17.93	29.63	40.00	-10.37	Q	V	
218.150	48.75	-17.77	30.98	40.00	-9.02	Q	V	

REMARKS: 1. 30MHz to 1000MHz test is Applicable CISPR 22 / EN 55022 standard.

2. The other emission levels were very low against the limit.

3. P= Peak Reading; Q= Quasi-peak Reading A= Average Reading

Model No.	AEC-6410	Test Mode	Mode 1
Environmental Conditions	25deg.C, 55% RH, 1005 hPa	6dB Bandwidth	120 KHz
Antenna Pole	Horizontal	Antenna Distance	10m
Detector Function	Quasi-peak.	Tested by	John Yen

Report No.: 81014202-F

(The chart below shows the highest readings taken from the final data.)

	Six Highest Radiated Emission Readings							
Fre	Frequency Range Investigated			30 M	[Hz to 1000]	MHz at 10	m	
Freq. (MHz)	Reading (dBuV)	Factor (dB)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Remark (P/Q/A)	Pol. (H/V)	
32.127	41.50	-11.54	29.96	40.00	-10.04	Q	Н	
186.154	46.96	-18.25	28.71	40.00	-11.29	Q	Н	
192.039	44.52	-18.25	26.27	40.00	-13.73	Q	Н	
208.040	47.96	-18.03	29.93	40.00	-10.07	Q	Н	
212.030	48.63	-17.93	30.70	40.00	-9.30	Q	Н	
218.140	44.25	-17.77	26.48	40.00	-13.52	Q	Н	

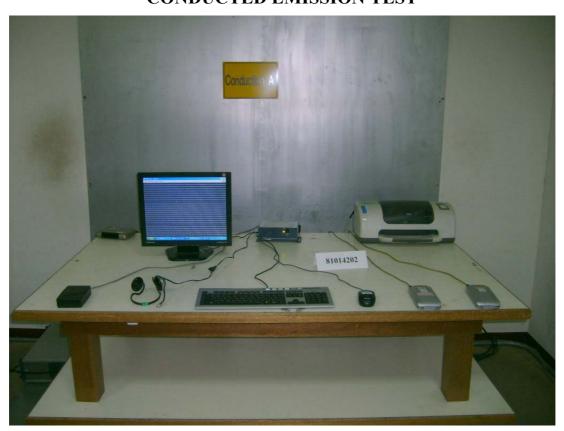
REMARKS: 1. 30MHz to 1000MHz test is Applicable CISPR 22 / EN 55022 standard.

2. The other emission levels were very low against the limit.

3. P= Peak Reading; Q= Quasi-peak Reading A= Average Reading



PHOTOGRAPHS OF THE TEST CONFIGURATION **CONDUCTED EMISSION TEST**







COMPLIANCE Certification Services Inc.

Report No.: 81014202-F

RADIATED EMISSION TEST



